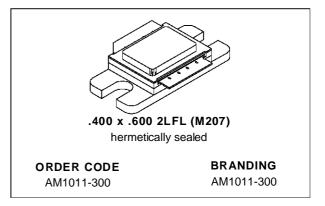
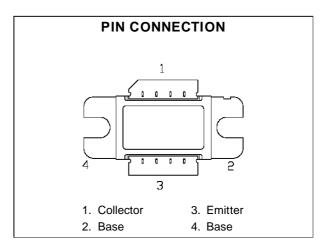


# AM1011-300

# RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTING
- LOW RF THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- Pout = 325 W MIN. WITH 7.7 dB GAIN
- 1030/1090 MHZ OPERATION





### DESCRIPTION

The AM1011-300 is a rugged, Class C common base device specifically designed for new Mode-S interrogator and transponder applications.

Minimal amplitude droop over the heavy Mode-S pulse burst is guaranteed by a thermal design incorporating an overlay site-ballasted die geometry.

ABSOLUTE MAXIMUM RATINGS	$(T_{case} = 25^{\circ}C)$
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Symbol	Parameter	Value	Unit
PDISS	Power Dissipation $(T_C \le 100^{\circ}C)^*$	1070	W
Ι <sub>C</sub>	Device Current*	36	A
Vcc	Collector-Supply Voltage*	43	V
TJ	Junction Temperature (Pulsed RF operation)	+250	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

#### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	0.14	°C/W
*Applies only to rated R	F amplifier operation.		

# **ELECTRICAL SPECIFICATIONS** ( $T_{case} = 25^{\circ}C$ )

# STATIC

Symbol	Test Conditions	Value			Unit		
		Min.	Тур.	Max.	Unit		
ВУсво	I <sub>C</sub> = 75 mA	$I_E = 0 \text{ mA}$		65	_	_	V
BV <sub>CES</sub>	I <sub>C</sub> = 75 mA	$V_{BE} = 0 V$		65	_	_	V
BV <sub>EBO</sub>	I <sub>C</sub> = 25 mA	$I_C = 0 \text{ mA}$		3.0	—	_	V
ICES	$V_{CE} = 40 V$	$V_{BE} = 0 V$		—	—	30	mA
h <sub>FE</sub>	$V_{CE} = 5 V$	I <sub>C</sub> = 10 A		10		_	—

#### DYNAMIC

Symbol Test Conditions		Value			Unit		
		Min.	Тур.	Max.	Unit		
Роит	f = 1090 MHz	$P_{IN} = 55 W$	$V_{CC} = 40 V$	325	350		W
hc	f = 1090 MHz	Pout = 325 W	$V_{CC} = 40 V$	40	45		%
GP	f = 1090 MHz	Pout = 325 W	$V_{CC} = 40 V$	7.7	8.0	_	dB

Pulse Conditions: Pulse width =  $200\mu$ s, Duty Cycle = 5%, are equivalent to the following

pulse burst conditions: Mode-S Interrogator (freq = 1030MHz)

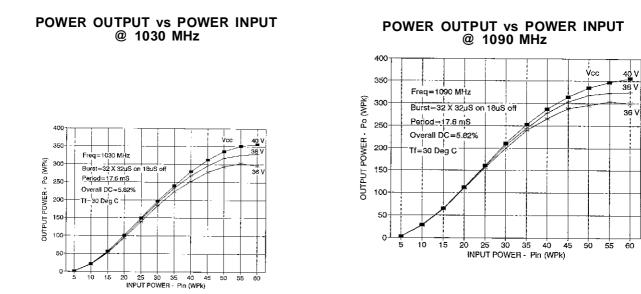
32 pulses, 32 $\mu$ s on, 18 $\mu$ s off, burst period = 17.6ms long term duty = 5.82%



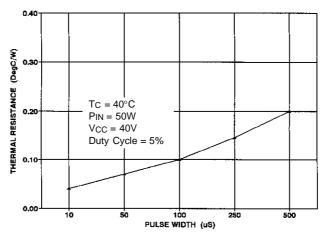
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#### **TYPICAL PERFORMANCE**

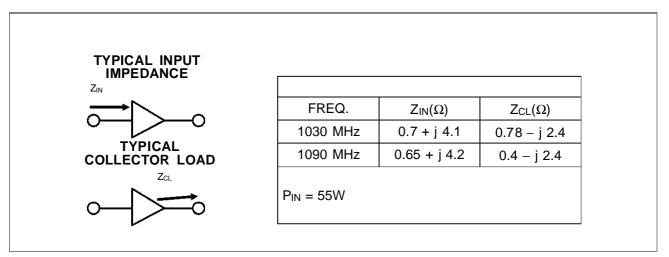


# MAXIMUM THERMAL RESISTANCE vs PULSE WIDTH

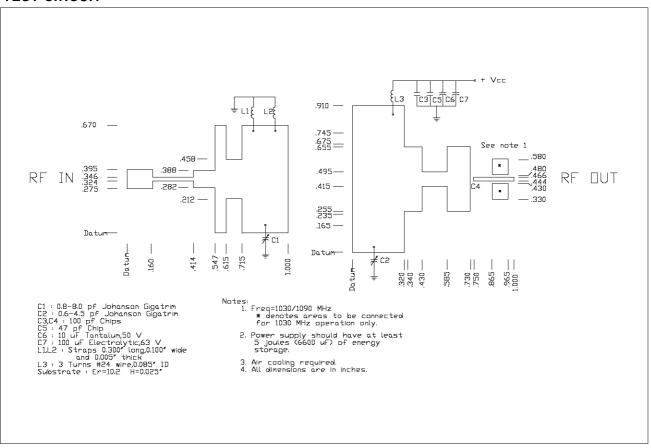




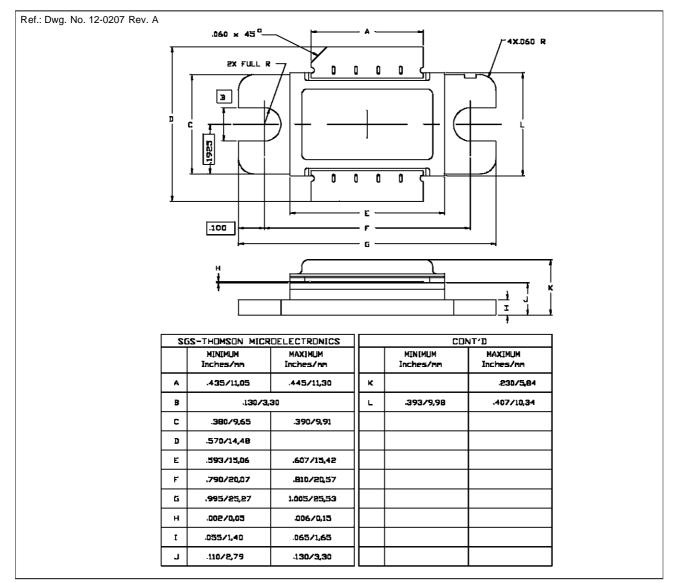
### **IMPEDANCE DATA**



**TEST CIRCUIT** 



## PACKAGE MECHANICAL DATA



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